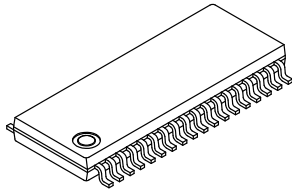


MECHANICAL CASE OUTLINE
PACKAGE DIMENSIONS

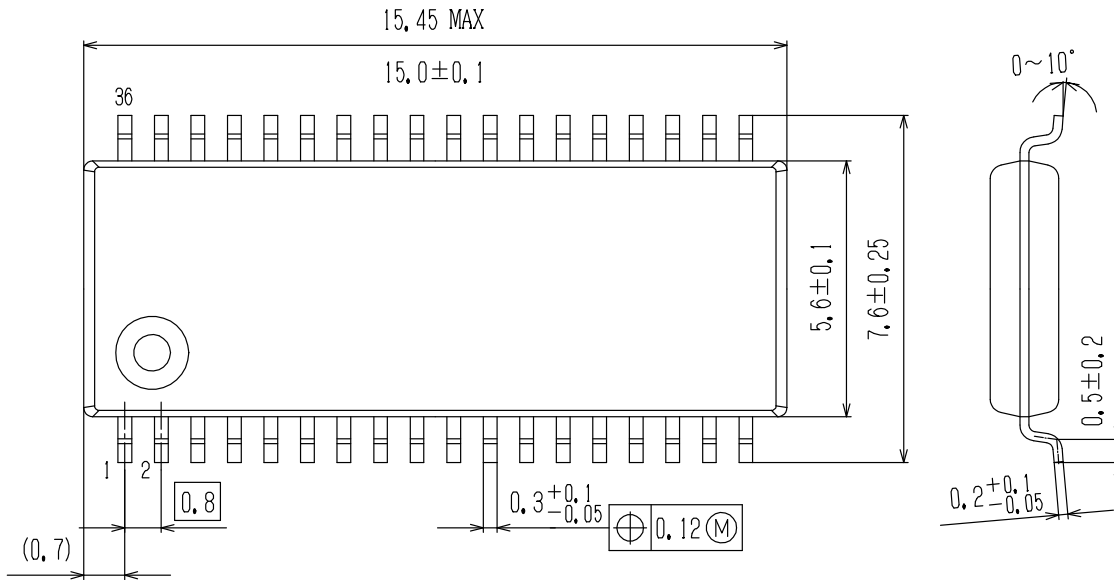
SSOP36J (275mil) Exposed Pad
CASE 940AH
ISSUE A

DATE 25 NOV 2013

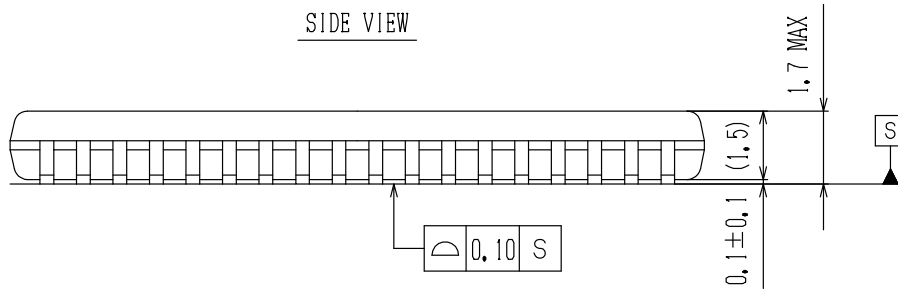


TOP VIEW

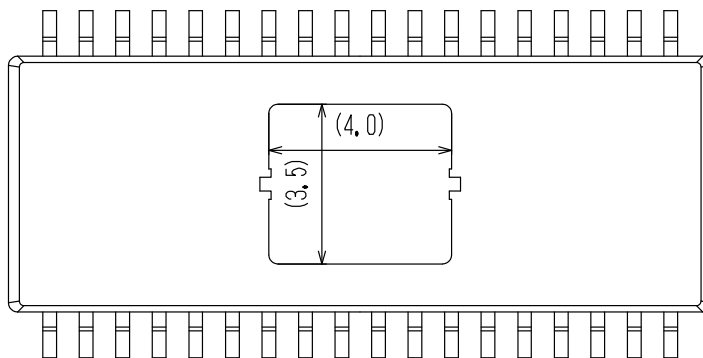
SIDE VIEW



SIDE VIEW

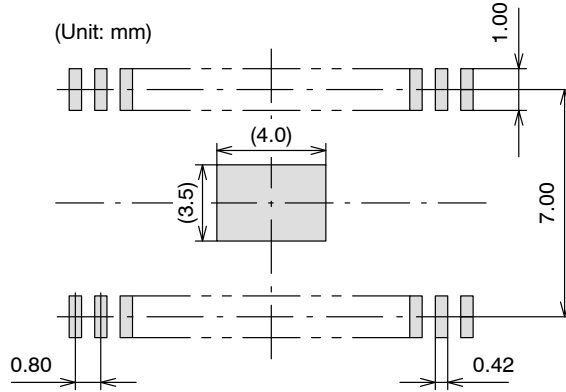


BOTTOM VIEW



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NEW STANDARD:		
DESCRIPTION:	SSOP36J (275MIL) EXPOSED PAD	PAGE 1 OF 3

SOLDERING FOOTPRINT*

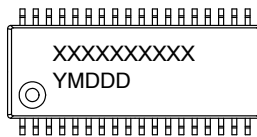


NOTES:

1. The measurements are for reference only, and unable to guarantee.
2. Please take appropriate action to design the actual Exposed Die Pad and Fin portion.
3. After setting, verification on the product must be done.
 (Although there are no recommended design for Exposed Die Pad and Fin portion Metal mask and shape for Through-Hole pitch (Pitch & Via etc), checking the soldered joint condition and reliability verification of soldered joint will be needed. Void ▀ gradient ▀ insufficient thickness of soldered joint or bond degradation could lead IC destruction because thermal conduction to substrate becomes poor.)

*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

GENERIC MARKING DIAGRAM*



XXXXX = Specific Device Code
 Y = Year
 M = Month
 DDD = Additional Traceability Data

*This information is generic. Please refer to device data sheet for actual part marking.
 Pb-Free indicator, "G" or microdot "▪", may or may not be present.

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DESCRIPTION:	SSOP36J (275MIL) EXPOSED PAD	PAGE 2 OF 3

